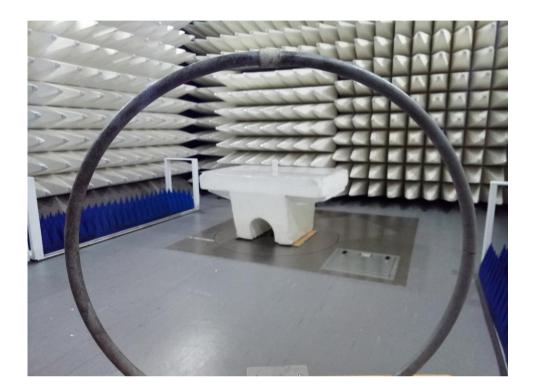
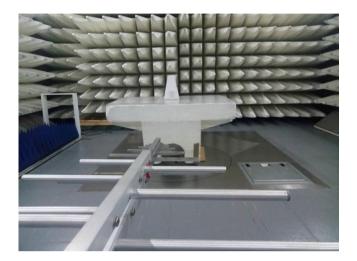


# Photograph No.1 Setup for spurious emission field strength measurements in the anechoic chamber below 30 MHz



## Photograph No.2 Setup for hopping frequencies and spurious emission field strength measurements in the anechoic chamber in 30 – 1000 MHz range



### Photograph No.3 Setup for spurious emission field strength measurements in the anechoic chamber above 1000 MHz range



## Photograph No.4 Setup for spurious emission field strength measurements in the anechoic chamber, EUT close view



# Photograph No.5 Setup for OBW measurements



# Photograph No.6 Setup for band edge emissions and hopping parameters measurements

